

<b>LIST OF ART CITED BY APPLICANT</b> <b>(PTO-1449)</b>			ATTY. DOCKET NO. IK-0138	APPLN. SERIAL NO. <b>NEW U.S. APPLICATION</b>		
			APPLICANT(S) <b>Seung Jin OH</b>			
			FILING DATE <b>June 12, 2006</b>	GROUP		
<b>U.S. PATENT DOCUMENTS</b>						
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	
<b>U.S. PATENT APPLICATION PUBLICATIONS</b>						
	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	
<b>U.S. PATENT APPLICATIONS</b>						
	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	
<b>FOREIGN PATENT DOCUMENTS</b>						
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation
	KR2001-113400	12/28/2001	KOREA (Full Korean Text and English Abstract Only)			Yes XX
	KR2002-29506	4/19/2002	KOREA (Full Korean Text and English Abstract Only)			XX
	KR2002-57634	7/12/2002	KOREA (Full Korean Text and English Abstract Only)			XX
	JP2001-324258	11/22/2001	JAPAN (Full Japanese Text and English Abstract Only)			XX
	JP2002-243354	8/28/2002	JAPAN (Full Japanese Text and English Abstract Only)			XX
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)</b>						
EXAMINER	/Stephanie McLaren/		DATE CONSIDERED		12/19/2008	

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**ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /S.M./**  
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